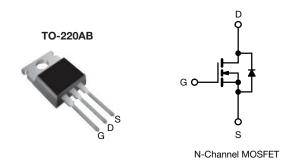
Vishay Siliconix

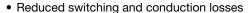
E Series Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	850				
R _{DS(on)} typ. (Ω) at 25 °C	$V_{GS} = 10 \text{ V}$	0.205			
Q _g max. (nC)	72				
Q _{gs} (nC)	9				
Q _{gd} (nC)	22				
Configuration	Single				

FEATURES

- Low figure-of-merit (FOM) Ron x Qq
- Low effective capacitance (Co(er))



Avalanche energy rated (UIS)

 Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>



FREE

APPLICATIONS

- · Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Solar (PV inverters)

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free and halogen-free	SiHP21N80AE-GE3

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V _{DS}	800		
Gate-source voltage			V _{GS}	± 30	V	
Continuous drain current (T _J = 150 °C)	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	- I _D	17.4	А	
	V _{GS} at 10 V	T _C = 100 °C		11		
Pulsed drain current ^a			I _{DM}	38		
Linear derating factor				1.4	W/°C	
Single pulse avalanche energy b			E _{AS}	127	mJ	
Maximum power dissipation			P _D	179	W	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C	
Drain-source voltage slope $T_J = 125 ^{\circ}\text{C}$		dv/dt	70	\//		
Reverse diode dv/dt ^d			39	V/ns		
Soldering recommendations (peak temperature) c For 10 s				260	°C	

Notos

- a. Repetitive rating; pulse width limited by maximum junction temperature
- b. V_{DD} = 140 V, starting T_J = 25 °C, L = 28.2 mH, R_q = 25 Ω , I_{AS} = 3 A
- c. 1.6 mm from case
- d. $I_{SD} \le I_D$, di/dt = 100 A/ μ s, starting $T_J = 25$ °C



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R_{thJA}	-	62	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	0.7	G/ VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		800	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.8	-	V/°C
Gate-source threshold voltage (N)	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Osta sauma laskana		V _{GS} = ± 20 V		-	-	± 100	nA
Gate-source leakage	I_{GSS}	$V_{GS} = \pm 30 \text{ V}$		-	-	± 1	μΑ
Z		V _{DS} =	V _{DS} = 800 V, V _{GS} = 0 V		-	1	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 640 V	, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 11 A	-	0.205	0.235	Ω
Forward transconductance a	9 _{fs}	V _{DS}	= 30 V, I _D = 3 A	-	4.0	-	S
Dynamic							
Input capacitance	C _{iss}		V _{GS} = 0 V,	-	1388	-	
Output capacitance	C _{oss}	Ţ ,	V _{DS} = 100 V,		53	-	pF
Reverse transfer capacitance	C _{rss}	f = 1 MHz		-	5	-	
Effective output capacitance, energy related ^a	C _{o(er)}	V 0VI 400VV 0V		-	43	-	
Effective output capacitance, time related ^b	$C_{o(tr)}$	V _{DS} = 0 V	$V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$		276	-	
Total gate charge	Qg			-	48	72	
Gate-source charge	Q_{gs}	$V_{GS} = 10 \text{ V}$	V _{GS} = 10 V I _D = 11 A, V _{DS} = 640 V		9	-	nC
Gate-drain charge	Q_gd			-	22	-	
Turn-on delay time	$t_{d(on)}$			-	21	42	
Rise time	t _r	$V_{DD} = 640 \text{ V}, I_D = 11 \text{ A},$		-	38	76	- ns
Turn-off delay time	$t_{d(off)}$	V _{GS} =	$V_{GS} = 10 \text{ V}, R_g = 20 \Omega$		71	107	
Fall time	t _f			-	76	114	
Gate input resistance	R_{g}	f = 1 MHz, open drain		0.2	0.55	1.1	Ω
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	17.4	
Pulsed diode forward current	I _{SM}			-	-	38	Α
Diode forward voltage	V _{SD}	T _J = 25 °C	T _J = 25 °C, I _S = 11 A, V _{GS} = 0 V		-	1.2	V
Reverse recovery time	t _{rr}			-	400	800	ns
Reverse recovery charge	Q _{rr}		5 °C, I _F = I _S = 11 A, 100 A/µs, V _B = 25 V	-	5	10	μC
Reverse recovery current	I _{RRM}	ai/at =	100 AV µS, VR = 20 V	-	20	-	A

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}
- b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

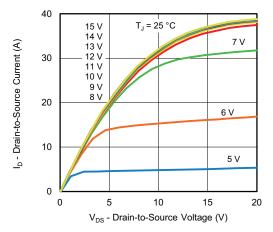


Fig. 1 - Typical Output Characteristics

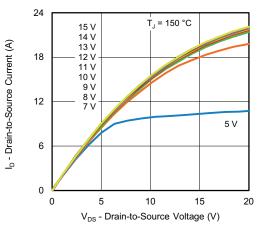


Fig. 2 - Typical Output Characteristics

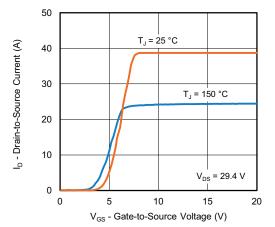


Fig. 3 - Typical Transfer Characteristics

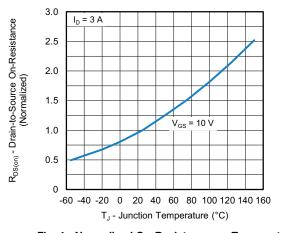


Fig. 4 - Normalized On-Resistance vs. Temperature

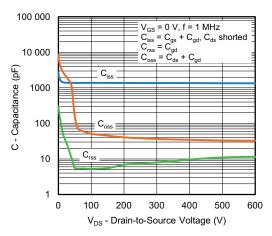


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

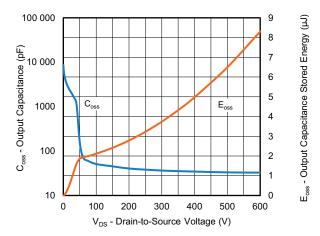


Fig. 6 - Coss and Eoss vs. VDS



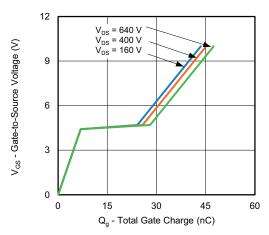


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

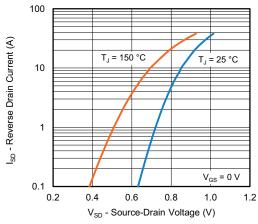


Fig. 8 - Typical Source-Drain Diode Forward Voltage

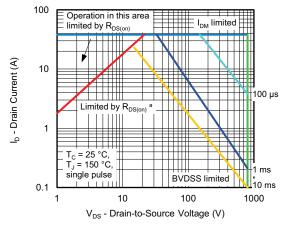


Fig. 9 - Maximum Safe Operating Area



a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

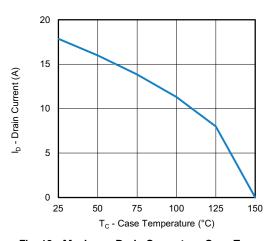


Fig. 10 - Maximum Drain Current vs. Case Temperature

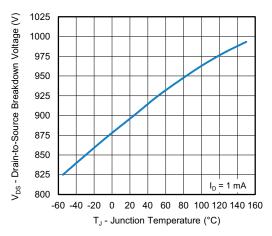


Fig. 11 - Temperature vs. Drain-to-Source Voltage



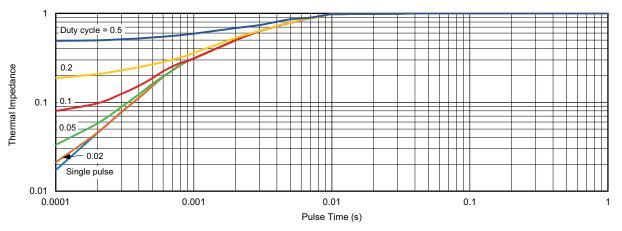


Fig. 12 - Normalized Transient Thermal Impedance, Junction-to-Case

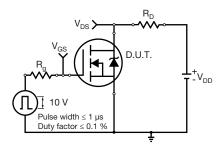


Fig. 13 - Switching Time Test Circuit

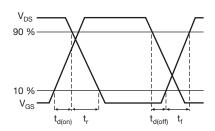


Fig. 14 - Switching Time Waveforms

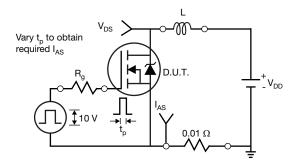


Fig. 15 - Unclamped Inductive Test Circuit

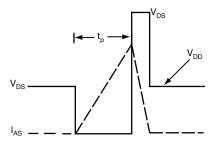


Fig. 16 - Unclamped Inductive Waveforms

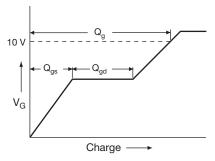


Fig. 17 - Basic Gate Charge Waveform

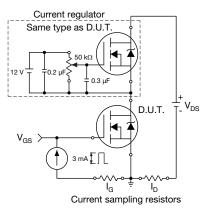
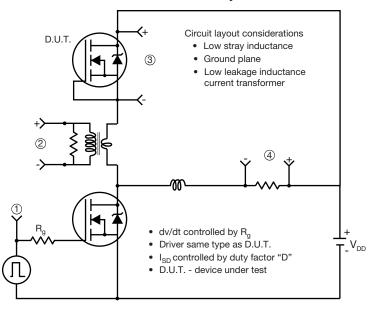


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dv/dt Test Circuit



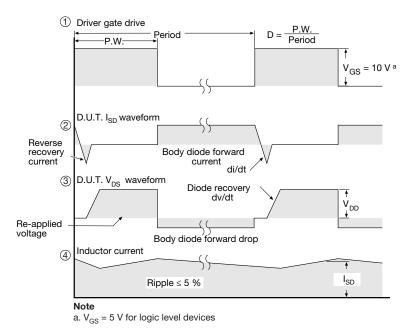
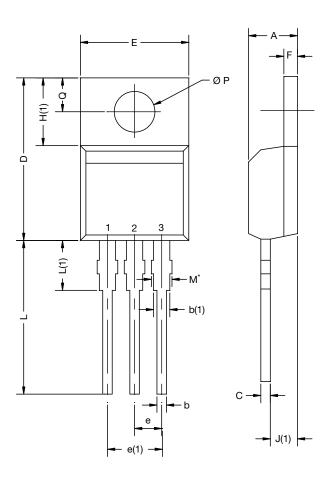


Fig. 19 - For N-Channel

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TO-220-1



DIM.	MILLIN	METERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
Е	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØΡ	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	

Note

• $M^* = 0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM

Revison: 04-Nov-2021 1 Document Number: 66542

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